TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2417

Chopper Regulator, DC-DC Converter and Motor Drive Applications

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : R_{DS} \, (\text{ON}) = 0.42 \, \Omega \, (\text{typ.}) \\ \bullet & \text{High forward transfer admittance} & : | \, Y_{fs} \, | \, = 7.5 \, S \, (\text{typ.}) \\ \bullet & \text{Low leakage current} & : \, I_{DSS} = 100 \, \, \mu\text{A} \, (\text{max}) \, (\text{V}_{DS} = 250 \, \text{V}) \\ \bullet & \text{Enhancement-mode} & : \, V_{th} = 1.5 \text{$^{\circ}$} 3.5 \, V \, (\text{V}_{DS} = 10 \, \text{V}, \, I_{D} = 1 \, \text{mA}) \\ \end{array}$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	250	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	7.5	Α	
	Pulse (Note 1)	I _{DP}	30	Α	
Drain power dissipatio	n (Tc = 25°C)	P _D	30	W	
Single pulse avalanche energy (Note 2)		E _{AS}	110	mJ	
Avalanche current		I _{AR}	7.5	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	3	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	4.16	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 3.3 mH, R_G = 25 Ω , I_{AR} = 7.5 A

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device.

Please handle with caution.

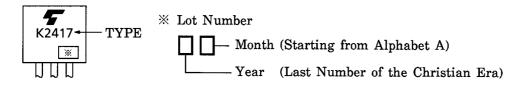
Electrical Characteristics (Ta = 25°C)

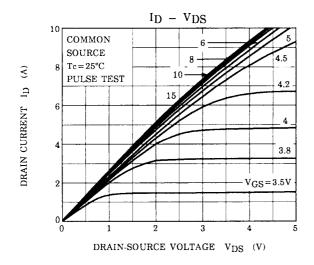
Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cur	rent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	250	_	_	V
Gate threshold v	roltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source OI	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3.5 A	-	0.42	0.5	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3.5 A	4	7.5		S
Input capacitano	е	C _{iss}		_	700	_	
Reverse transfer	capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		80	_	pF
Output capacitar	Output capacitance C _{oss}		_	270	_		
Switching time	Rise time	t _r	V_{GS} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT}	_	10	_	- ns
	Turn-on time	t _{on}		_	20	_	
	Fall time	t _f		_	10	_	
	Turn-off time	t _{off}	$V_{DD} = 100V$ Duty $\leq 1\%$, $t_w = 10\mu s$	_	70	_	
Total gate charg plus gate-drain)		Q_{g}		1	20	ı	
Gate-source charge		Q _{gs}	$V_{DD} \approx 200 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 7.5 \text{ A}$		13	_	nC
Gate-drain ("miller") charge		Q_{gd}			7	_	

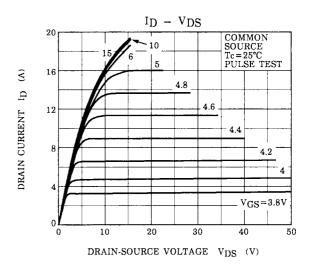
Source-Drain Ratings and Characteristics (Ta = 25°C)

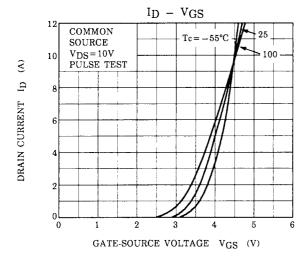
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_		_	7.5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_		_	30	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 7.5 A, V _{GS} = 0 V	_	_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 7.5 A, V _{GS} = 0 V	-	180	-	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 100 Å / μs	_	1.1	_	μC

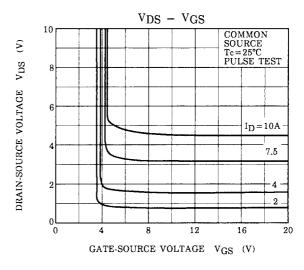
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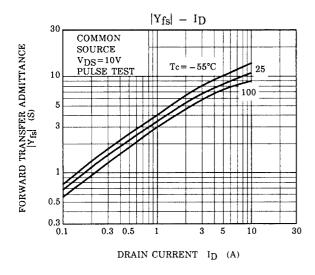


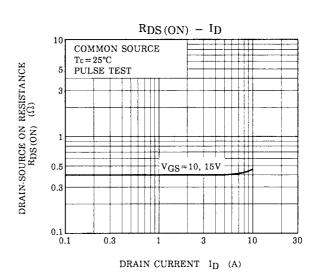


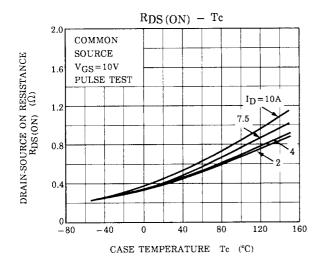


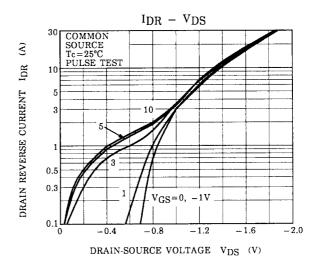


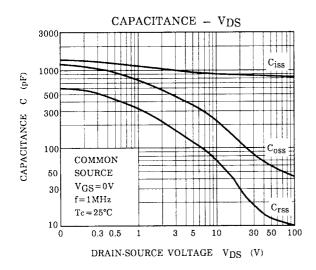


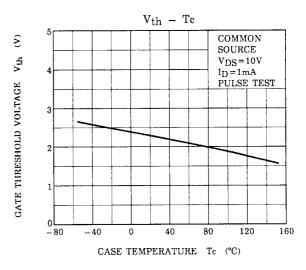


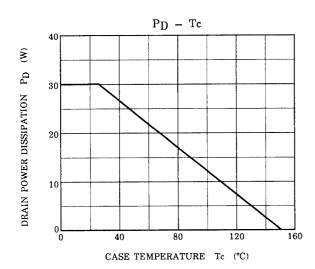






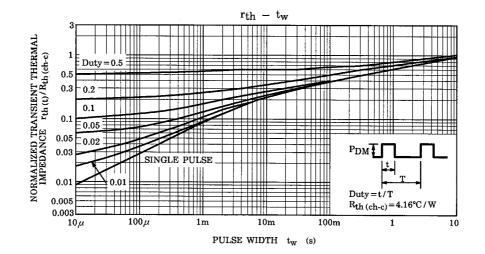


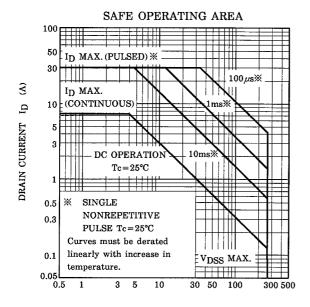




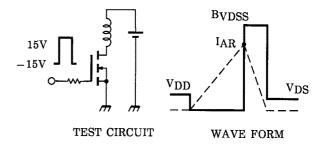
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DRAIN-SOURCE VOLTAGE V_{DS} (V)



$$\begin{split} R_G &= 25~\Omega \\ V_{DD} &= 50~V,\, L = 3.3~mH \end{split}$$

$$EAS = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

RESTRICTIONS ON PRODUCT USE

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